Se	arch	Notes	lotes		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/525,264	BOYD ET AL.
Examiner	Art Unit
Karen Cheng	1626

SEARCHED			
Class	Subclass	Date	Examiner
544	381	2/5/2007	кс
546	79	2/5/2007	кс
546	195	2/5/2007	кс
548	241	2/5/2007	кс
548	427	2/5/2007	кс

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
-			
	1		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
STN Structure Search (see attached)	1/29/2007	кс
Inventor Name Search (PALM)	1/31/2007	кс
EAST Search (see attached)	2/5/2007	кс